

<b>Notice of References Cited</b>	Application/Control No. 09/750,552	Applicant(s)/Patent Under Reexamination KLASSEN ET AL.	
	Examiner Madeleine AV Nguyen	Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,760,489 B1	07-2004	Kuwata, Naoki	382/300
*	B	US-5,142,675 A	08-1992	Oi et al.	718/104
*	C	US-5,398,121 A	03-1995	Kowalewski et al.	358/504
*	D	US-5,432,892 A	07-1995	Hafner et al.	345/591
*	E	US-5,581,376 A	12-1996	Harrington, Steven J.	358/518
*	F	US-5,751,926 A	05-1998	Kasson et al.	345/419
*	G	US-6,040,925 A	03-2000	Vondran et al.	358/525
*	H	US-6,985,543 B1	01-2006	Sutardja, Pantas	375/345
*	I	US-6,163,617 A	12-2000	Heuscher et al.	382/132
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.